

Notice of References Cited		Application/Control No. 10/616,018	Applicant(s)/Patent Under Reexamination ALBERT ET AL.	
		Examiner Chong H. Kim	Art Unit 3682	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,160,708	12-2000	Loibl et al.	361/704
B	US-6,396,692	05-2002	Farshi et al.	361/690
C	US-5,361,650	11-1994	Klecker et al.	74/606R
D	US-4,559,864	12-1985	Sakakibara et al.	91/454
E	US-5,245,508	09-1993	Mizzi, John V.	361/694
F	US-6,411,512 B1	06-2002	Mankaruse et al.	361/700
G	US-5,276,584	01-1994	Collins et al.	361/718
H	US-4,378,760	04-1983	Barge, Jean	123/41.12
I	US-6,679,137 B1	01-2004	Bek, Manfred	74/606R
J	US-5,848,848	12-1998	St. Jean, David L.	400/88
K	US-5,662,007	09-1997	Starker et al.	74/606A
L	US-5,823,070	10-1998	Taniguchi et al.	74/606R
M	US-5,709,134	01-1998	Ulm, Michael	74/606R

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	DE 29513950 U1	01-1997	Germany	Siemens AG	B60K 41/06
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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